

## AP500X

### AP500X Water Soluble Flux

AP500X is a water soluble halogen zero tacky flux specifically engineered for ultra-fine bump pitch flip chip attach and BGA attach applications. AP500X flux delivers superior wettability on various pad finishes such as Copper Organic Solderability Preservative (CuOSP) and Electroless Nickel Immersion Gold (ENIG), and offers long work life and easy cleanability by DI water after reflow.

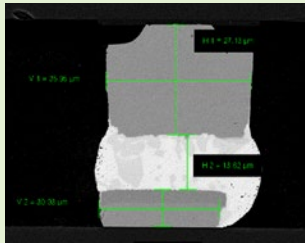
#### Key Features

- Water soluble
- Halogen zero
- Superior wettability
- $\geq 12$ hr work life
- Effective removal of OSP layer on Cu OSP pads
- Enables ultra-fine bump pitch flip chip attach with zero defects

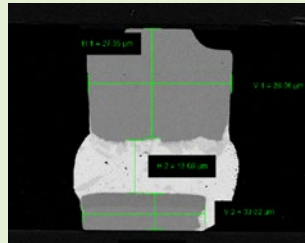
## Ultra-Fine Bump Pitch Flip Chip Attach : X-SEM Analysis



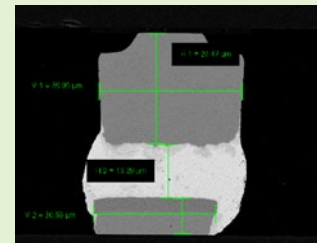
Bump 1



Bump 2



Bump 3



- AP500X showed good wetting with 30~35µm Cu pillar bump on ENIG surface.
- No cold joint, solder creeping or bridging observed at Cu pillar joints after reflow.

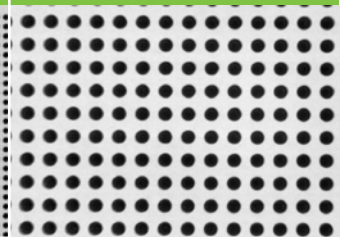
### Flip Chip Test Vehicle Details

Chip size	2x3mm
Cu pillar size	35µm
Cu pillar pitch	60µm
Cu pillar height	40µm
Cu pillar alloy	Cu + SnAg

### X-Ray Imaging Overview



### X-Ray Imaging Center



No significant solder void observed at the Cu pillar bump under X-ray inspection.

## Organic Solderability Preservative (OSP) Removal

600 X 700 µm Cu OSP Pads	Before Reflow - Control	Reflow with Flux A - Ineffective OSP Removal	Reflow with AP500X Flux - Effective OSP Removal																																										
Light optical microscope observation																																													
Element analysis (SEM-EDX)	<table border="1"> <tr><td>S8</td><td>Wt%</td><td>σ</td></tr> <tr><td>Cu</td><td>59.2</td><td>0.4</td></tr> <tr><td>C</td><td>36.5</td><td>0.3</td></tr> <tr><td>N</td><td>2.7</td><td>0.4</td></tr> <tr><td>O</td><td>1.6</td><td>0.1</td></tr> </table>	S8	Wt%	σ	Cu	59.2	0.4	C	36.5	0.3	N	2.7	0.4	O	1.6	0.1	<table border="1"> <tr><td>S12</td><td>Wt%</td><td>σ</td></tr> <tr><td>Cu</td><td>79.7</td><td>0.4</td></tr> <tr><td>C</td><td>15.3</td><td>0.3</td></tr> <tr><td>N</td><td>3.4</td><td>0.3</td></tr> <tr><td>O</td><td>1.6</td><td>0.1</td></tr> </table>	S12	Wt%	σ	Cu	79.7	0.4	C	15.3	0.3	N	3.4	0.3	O	1.6	0.1	<table border="1"> <tr><td>S4</td><td>Wt%</td><td>σ</td></tr> <tr><td>Cu</td><td>94.8</td><td>0.4</td></tr> <tr><td>C</td><td>4.4</td><td>0.3</td></tr> <tr><td>O</td><td>0.8</td><td>0.2</td></tr> </table>	S4	Wt%	σ	Cu	94.8	0.4	C	4.4	0.3	O	0.8	0.2
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- OSP are organic compounds containing significant amount of C, N and O.
- AP500X flux effectively removes OSP layer

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